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1995, no persons are required to respond to a collection of information unless it contains a valid OMB control number. Complete if Known TRADE Substitute for form 1449 **Application Number** 10/766,121 INFORMATION DISCLOSURE Filing Date January 27, 2004 STATEMENT BY APPLICANT First Named Inventor Chengjun Liu Art Unit 2624 (Use as many sheets as necessary) **Examiner Name** Wenpeng Chen **Attorney Docket Number** Sheet 3 436/5

		NON PATENT LITERATURE DOCUMENTS	
Examiner Initials*	Cite No. <sup>1</sup>	Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published.	T²
line	BA	International Search Report, dated 3/21/2005.	
an	ВВ	CHELLAPPA et al.; Human And Machine Recognition of Faces: A Survey; Proc. IEEE; May, 1995; Vol. 83; No. 5; pp. 705-740.	
m	₿C	DASS et al.; Markov Face Models; The Eighth IEEE Int'l Conf. on Computer Vision; 2001; pp. 680-687.	
m	√BD	HEISELE et al.; Face Detection In Still Gray Images; A.I. Memo AIM-1687; Artificial Intelligence Laboratory; May 2000; pp. 1-25.	
mi	BE	HJELMAS et al.; Face Detection: A Survey; Computer Vision and Image Understanding; 2001; Vol. 83; pp. 236-274.	
me	BF	P. HO; Rotation Invariant Real-Time Face Detection And Recognition System; A.I. Memo AIM-2001-010; 05/31/01; Artificial Intelligence Lab.; pp. 1-24.	
w	_BG	HSU et al.; Face Detection In Color Images; Int'l Conference on Image Processing; 2001; pp. 1046-1049.	
m	вн	LIU et al.; Evolutionary Pursuit And Its Application To Face Recognition; IEEE Trans. Pattern Analysis and Machine Intelligence; 2000; Vol. 22; No. 6; pp. 570-582.	
m	BI	LIU et al.; Robust Coding Schemes For Indexing And Retrieval From Large Face Databases; IEEE Trans. on Image Proc.; 2000; Vol. 9; No. 1; pp. 1-16.	
in		LIU et al.; A Shape And Texture Based Enhanced Fisher Classifier For Face Recognition; IEEE Trans. on Image Proc.; 2001; Vol. 10; No. 4; pp. 1-35.	

Examiner	WENPENG CHEN	(1)	Date	( ) ( )	212-
Signature		Unsu	Considered	5//9	105

<sup>\*</sup>EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

Applicant's unique citation designation number (optional). <sup>2</sup> Applicant is to place a check mark here if English language Translation is attached.

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Substitute for form 1449/PTO				Complete if Known		
30050101	8 101 101111 1443/-10			Application Number	10/766,121	
INFO	ORMATION	DIS	CLOSURE	Filing Date	January 27, 2004	
STA	TEMENT B	Y A	PPLICANT	First Named Inventor	Chengjun Liu	
				Art Unit	2624	
	(Use as many she	ets as n	ecessary)	Examiner Name	Wenpeng Chen	
Sheet	2	of	3	Attorney Docket Number	436/5	

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m	вк	LIU et al.; Gabor Feature Based Classification Using The Enhanced Fisher Linear Disciminant Model For Face Rec.; IEEE Trans. on Image Proc.; 2002; Vol 11; No. 4; pp. 1-36.	
m	BL	MOGHADDAM et al.; Probabilistic Visual Learning For Object Representation; IEEE Trans. Pattern Analysis and Machine Intelligence; 1997; Vol. 19; No.7; pp. 1-31.	
m	ВМ	MOHAN et al.; Eample-Based Object Detection In Images By Components; IEEE Trans. Pattern Analysis and Machine Intelligence; 2001; Vol. 23; No. 4; pp. 349-361.	
twe	BN	PAPAGEORGIOU et al.; A General Framework For Object Detection; Int'l Conference on Computer Vision; Jan. 1998; pp. 555-562.	
an	во	PENTLAND et al.; View-Based And Modular Eigenspaces For Face Recognition; Proc. Computer Vision and Pattern Recognition; 1994; pp. 84-91.	
m	ВР	PHILLIPS et al.; The Feret Database And Evaluation Procedure For Face-Recognition Algorithms; Image and Vision Computing; 1998; Vol. 16; pp. 295-306.	
me	ВQ	Qian et al.; Object Detection Using Hierarchical MRF and MAP Estimation; Proc. Computer Vision and Pattern Recognition; 1997; pp. 186-192.	
Cure	BR	ROWLEY et al.; Neural Network-Based Face Detection; IEEE Trans. Pattern Analysis and Machine Intelligence; 1998; Vol. 20; No. 1; pp. 1-28.	
m	BS	ROWLEY et al.; Rotation Invariant Neural Network-Based Face Detection; Proc. IEEE Computer Society Conf. on Computer Vision and Pattern Recognition; 1998; pp. 38-44.	
m	ВТ	SAMAL et al.; Automatic Recognition And Analysis Of Human Faces And Facial Expressions: A Survey; Pattern Recognition; 1992; Vol. 25; No. 1; pp. 65-77.	

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Signature	PRIMARY EXAMINER	/// c	onsidered \( \langle \frac{1}{2} \)	1108

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Substitu	ite for form 1449/PTO			Complete if Known		
Subsuit	ite for form 1443/F10			Application Number	10/766,121	
INF	ORMATION	DIS	CLOSURE	Filing Date	January 27, 2004	
STA	ATEMENT E	BY A	PPLICANT	First Named Inventor	Chengjun Liu	
	#4	4		Art Unit	2624	
	(Use as many she	ers as r	recessary)	Examiner Name	Wenpeng Chen	
Sheet	3	of	3	Attorney Docket Number	436/5	

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jur	-BU	SCHNEIDERMAN et al.; Probabilistic Modeling Of Local Appearance And Spatial Relationships For; Proc. IEEE Computer Society Conf. on Computer Vision and; 1998; pp. 1-7.	
m	BV	SCHNEIDERMAN et al.; A Statistical Method For 3D Object Detection Applied To Faces And Cars; Proc. IEEE Computer Society Conf. on Computer Vision and Pattern, 2000; pp 1-6.	
m	вw	SUNG et al.; Learning And Example Selection For Object And Pattern Detection; A.I.T.R. No. 1572; MIT; Jan. 1996; pp. 1-195.	
m	ВХ	SUNG et al.; Example-Based Learning For View-Based Human Face Detection; IEEE Trans. Pattern Analysis and Machine intelligence; 1998; Vol. 20; No. 1; pp. 39-51.	
are	-BY	VIOLA et al.; Rapid Object Detection Using A Boosted Cascade Of Simple Features; Proc. IEEE Computer Society Conf. on Computer Vision and Pattern Recognition; 2001; pp. 1-9.	
ju	BZ	YANG et al.; Face Detection Using Mixtures Of Linear Subspaces; Proc. Fifth Int'l Conf. on Automatic Face and Gesture Recognition; March 2000; pp. 1-7.	
m	∕CA	A. YUILLE; Deformable Templates For Face Recognition; Journal of Cognitive Neuroscience; 1991; Vol. 3; No. 1; pp. 59-70.	
m	_CB	K. FUKUNAGA; Introduction to Statistical Pattern Recognition; Second Edition, pp. 51-253 and 399-507.	
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Examiner	WENPENG CHEN	1/.	Date	11010
Signature	PRIMARY EXAMINER	mou	-Considered	5/19/03

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